

## DAC5675A-SP Radiation-Tolerant, 14-Bit, 400-MSPS Digital-to-Analog Converter

### 1 Features

- QMLV (QML Class V) MIL-PRF-38535 Qualified, SMD 5962-07204
  - 5962-0720401VXC – Qualified over the Military Temperature Range (–55°C to 125°C)
  - 5962-0720402VXC – Qualified over Reduced Temperature Range (–55°C to 115°C) for Improved Dynamic Performance
- High-Performance 52-Pin Ceramic Quad Flat Pack (HFG)
- 400-MSPS Update Rate
- LVDS-Compatible Input Interface
- Spurious-Free Dynamic Range (SFDR) to Nyquist
  - 69 dBc at 70 MHz IF, 400 MSPS
- W-CDMA Adjacent Channel Power Ratio (ACPR)
  - 73 dBc at 30.72 MHz IF, 122.88 MSPS
  - 71 dBc at 61.44 MHz IF, 245.76 MSPS
- Differential Scalable Current Outputs: 2 to 20 mA
- On-Chip 1.2-V Reference
- Single 3.3-V Supply Operation
- Power Dissipation: 660 mW at  $f_{CLK} = 400$  MSPS,  $f_{OUT} = 20$  MHz

### 2 Applications

- Radiation Hardened Digital to Analog (DAC) Applications
- Space Satellite RF Data Transmission
- Cellular Base Transceiver Station Transmit Channel:
  - CDMA: WCDMA, CDMA2000, IS-95
  - TDMA: GSM, IS-136, EDGE/GPRS
  - Supports Single-Carrier and Multicarrier Applications
- Engineering Evaluation (/EM) Samples are Available <sup>(1)</sup>

(1) These units are intended for engineering evaluation only. They are processed to a non-compliant flow (for example, no burn-in) and are tested to temperature rating of 25°C only. These units are not suitable for qualification, production, radiation testing or flight use. Parts are not warranted for performance on full MIL specified temperature range of –55°C to 125°C or operating life.

### 3 Description

The DAC5675A-SP is a radiation-tolerant, 14-bit resolution high-speed digital-to-analog converter (DAC) primarily suited for space satellite applications. The DAC5675A-SP is designed for high-speed digital data transmission in wired and wireless communication systems, high-frequency direct digital synthesis (DDS), and waveform reconstruction in test and measurement applications. The DAC5675A-SP has excellent SFDR at high intermediate frequencies, which makes it well suited for multicarrier transmission in TDMA and CDMA based cellular base transceiver stations (BTSs).

The DAC5675A-SP operates from a single supply voltage of 3.3 V. Power dissipation is 660 mW at  $f_{CLK} = 400$  MSPS,  $f_{OUT} = 70$  MHz. The DAC5675A-SP provides a nominal full-scale differential current output of 20 mA, supporting both single-ended and differential applications. The output current can be directly fed to the load with no additional external output buffer required. The output is referred to the analog supply voltage  $AV_{DD}$ .

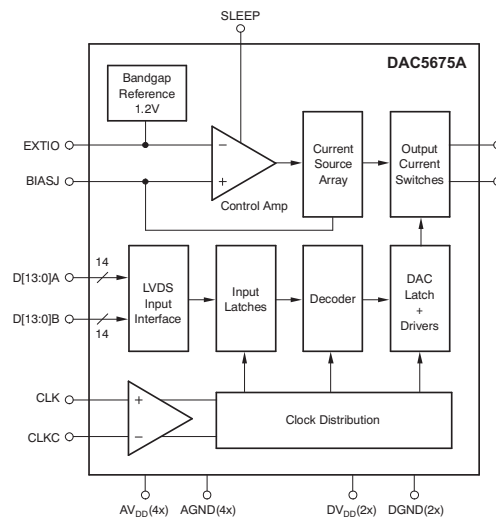
The DAC5675A-SP includes a low-voltage differential signaling (LVDS) interface for high-speed digital data input. LVDS features a low differential voltage swing with a low constant power consumption across frequency, allowing for high-speed data transmission with low noise levels (low electromagnetic interference (EMI)).

#### Device Information<sup>(1)</sup>

| PART NUMBER | PACKAGE       | BODY SIZE (NOM)     |
|-------------|---------------|---------------------|
| DAC5675A-SP | HFG (52 CQFP) | 19.05 mm x 19.05 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Simplified Schematic



## Table of Contents

|  |           |  |           |
|--|-----------|--|-----------|
| <b>1 Features</b> .....  | <b>1</b>  | 8.2 Functional Block Diagram .....                               | 14        |
| <b>2 Applications</b> .....  | <b>1</b>  | 8.3 Feature Description .....                                    | 14        |
| <b>3 Description</b> .....   | <b>1</b>  | 8.4 Device Functional Modes .....                                | 20        |
| <b>4 Revision History</b> .....                                    | <b>2</b>  | <b>9 Application and Implementation</b> .....                    | <b>21</b> |
| <b>5 Description (continued)</b> .....                             | <b>3</b>  | 9.1 Application Information .....                                | 21        |
| <b>6 Pin Configuration and Functions</b> .....                     | <b>4</b>  | 9.2 Typical Application .....                                    | 21        |
| <b>7 Specifications</b> .....                                      | <b>5</b>  | <b>10 Power Supply Recommendations</b> .....                     | <b>24</b> |
| 7.1 Absolute Maximum Ratings .....                                 | 5         | <b>11 Layout</b> .....   | 24        |
| 7.2 ESD Ratings .....  | 5         | 11.1 Layout Guidelines .....                                     | 24        |
| 7.3 Recommended Operating Conditions .....                         | 5         | 11.2 Layout Example .....  | 24        |
| 7.4 Thermal Information .....                                      | 5         | 11.3 Thermal Considerations .....                                | 25        |
| 7.5 DC Electrical Characteristics (Unchanged After 100 kRad) ..... | 6         | <b>12 Device and Documentation Support</b> .....                 | <b>27</b> |
| 7.6 AC Electrical Characteristics (Unchanged After 100 kRad) ..... | 8         | 12.1 Device Support .....  | 27        |
| 7.7 Digital Specifications (Unchanged After 100 kRad) .....        | 10        | 12.2 Receiving Notification of Documentation Updates .....       | 27        |
| 7.8 Electrical Characteristics .....                               | 11        | 12.3 Community Resources .....                                   | 27        |
| 7.9 Typical Characteristics .....                                  | 12        | 12.4 Trademarks .....  | 27        |
| <b>8 Detailed Description</b> .....                                | <b>14</b> | 12.5 Electrostatic Discharge Caution .....                       | 27        |
| 8.1 Overview .....   | 14        | 12.6 Glossary .....  | 28        |
|  |           | <b>13 Mechanical, Packaging, and Orderable Information</b> ..... | <b>28</b> |

## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| <b>Changes from Revision G (August 2014) to Revision H</b>   | <b>Page</b> |
|--|-------------|
| • Updated supply voltage absolute maximum rating for $AV_{DD}$ to $DV_{DD}$ .....                            | 5           |
| • Added sentence explaining $AV_{DD}$ and $DV_{DD}$ simultaneous ramp .....                                  | 24          |
| • Added <i>Receiving Notification of Documentation Updates</i> and <i>Community Resources</i> sections ..... | 27          |

| <b>Changes from Revision F (January 2014) to Revision G</b>  | <b>Page</b> |
|--|-------------|
| • Added <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section ..... | 1           |
| • Updated supply voltage absolute maximum ratings for $AV_{DD}$ to $DV_{DD}$ .....   | 5           |

| <b>Changes from Revision E (April 2013) to Revision F</b> | <b>Page</b> |
|---|-------------|
| • Added /EM bullet to <i>Features</i> .....               | 1           |
| • Deleted Ordering Information table .....                | 3           |

## 5 Description (continued)

LVDS is typically implemented in low-voltage digital CMOS processes, making it the ideal technology for high-speed interfacing between the DAC5675A-SP and high-speed low-voltage CMOS ASICs or FPGAs.

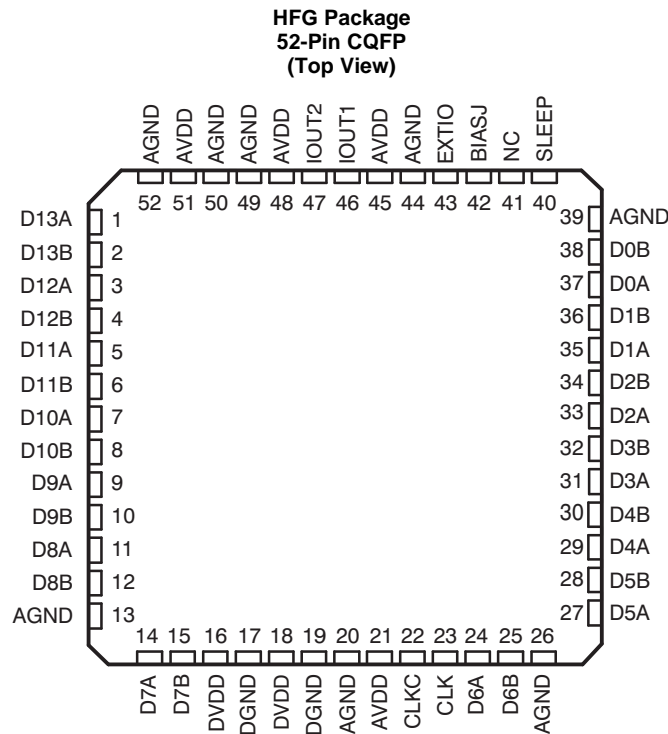
The DAC5675A-SP current-source-array architecture supports update rates of up to 400 MSPS. On-chip edge-triggered input latches provide for minimum setup and hold times, thereby relaxing interface timing.

The DAC5675A-SP is specifically designed for a differential transformer-coupled output with a 50- $\Omega$  doubly-terminated load. With the 20-mA full-scale output current, both a 4:1 impedance ratio (resulting in an output power of 4 dBm) and 1:1 impedance ratio transformer (–2 dBm) is supported. The last configuration is preferred for optimum performance at high output frequencies and update rates. The outputs are terminated to AVDD and have voltage compliance ranges from  $AV_{DD} - 1$  to  $AV_{DD} + 0.3$  V.

An accurate on-chip 1.2-V temperature-compensated bandgap reference and control amplifier allows the user to adjust this output current from 20 to 2 mA. This provides 20-dB gain range control capabilities. Alternatively, an external reference voltage may be applied. The DAC5675A-SP features a SLEEP mode, which reduces the standby power to approximately 18 mW.

The DAC5675A-SP is available in a 52-pin ceramic nonconductive tie-bar package (HFG). The device is specified for operation over the military temperature range of –55°C to 125°C and W temperature range of –55°C to 115°C.

## 6 Pin Configuration and Functions



**Pin Functions**

| PIN              |  | I/O | DESCRIPTION  |
|------------------|--|-----|--|
| NAME             | NO.  |     |  |
| AGND             | 13, 20, 26, 39, 44, 49, 50, 52                     | I   | Analog negative supply voltage (ground). Pin 13 is internally connected to the heat slug and lid (lid is also grounded internally).                  |
| AV <sub>DD</sub> | 21, 45, 48, 51                                     | I   | Analog positive supply voltage   |
| BIASJ            | 42   | O   | Full-scale output current bias   |
| CLK              | 23   | I   | External clock input   |
| CLKC             | 22   | I   | Complementary external clock   |
| D[13:0]A         | 1, 3, 5, 7, 9, 11, 14, 24, 27, 29, 31, 33, 35, 37  | I   | LVDS positive input, data bits 13–0. D13A is the most significant data bit (MSB). D0A is the least significant data bit (LSB).                       |
| D[13:0]B         | 2, 4, 6, 8, 10, 12, 15, 25, 28, 30, 32, 34, 36, 38 | I   | LVDS negative input, data bits 13–0. D13B is the most significant data bit (MSB). D0B is the least significant data bit (LSB).                       |
| DGND             | 17, 19   | I   | Digital negative supply voltage (ground)   |
| DV <sub>DD</sub> | 16, 18   | I   | Digital positive supply voltage  |
| EXTIO            | 43   | I/O | Internal reference output or external reference input. Requires a 0.1- $\mu$ F decoupling capacitor to AGND when used as reference output.           |
| IOUT1            | 46   | O   | DAC current output. Full-scale when all input bits are set '0'. Connect the reference side of the DAC load resistors to AV <sub>DD</sub> .           |
| IOUT2            | 47   | O   | DAC complementary current output. Full-scale when all input bits are '1'. Connect the reference side of the DAC load resistors to AV <sub>DD</sub> . |
| NC               | 41   |     | Not connected in chip. Can be high or low.   |
| SLEEP            | 40   | I   | Asynchronous hardware power-down input. Active high. Internal pulldown.  |

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating junction temperature range (unless otherwise noted)<sup>(1)</sup>

|   |                          | MIN  | MAX             | UNIT |
|---|--------------------------|------|-----------------|------|
| Supply voltage  | $A_{VDD}$ <sup>(2)</sup> | -0.3 | 3.6             | V    |
|   | $D_{VDD}$ <sup>(3)</sup> | -0.3 | 3.6             | V    |
|   | $A_{VDD}$ to $D_{VDD}$   | -0.7 | 0.7             | V    |
| Voltage between AGND and DGND                                   |                          | -0.3 | 0.5             | V    |
| CLK, CLKC <sup>(2)</sup>  |                          | -0.3 | $A_{VDD} + 0.3$ | V    |
| Digital input D[13:0]A, D[13:0]B <sup>(3)</sup> , SLEEP, DLLOFF |                          | -0.3 | $D_{VDD} + 0.3$ | V    |
| IOUT1, IOUT2 <sup>(2)</sup>                                     |                          | -1   | $A_{VDD} + 0.3$ | V    |
| EXTIO, BIASJ <sup>(2)</sup>                                     |                          | -1   | $A_{VDD} + 0.3$ | V    |
| Peak input current (any input)                                  |                          |      | 20              | mA   |
| Peak total input current (all inputs)                           |                          |      | -30             | mA   |
| Lead temperature 1.6 mm (1/16 inch) from the case for 10 s      |                          |      | 260             | °C   |
| Storage temperature, $T_{stg}$                                  |                          | -65  | 150             | °C   |

(1) Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- (2) Measured with respect to AGND  
 (3) Measured with respect to DGND

### 7.2 ESD Ratings

|           |                         |   | VALUE | UNIT |
|-----------|-------------------------|---|-------|------|
| $V_{ESD}$ | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup> | ±4000 | V    |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating junction temperature range (unless otherwise noted)

|           |                                | MIN          | NOM | MAX | UNIT |
|-----------|--------------------------------|--------------|-----|-----|------|
| $A_{VDD}$ | Analog supply voltage          | 3.15         | 3.3 | 3.6 | V    |
| $D_{VDD}$ | Digital supply voltage         | 3.15         | 3.3 | 3.6 | V    |
| $T_J$     | Operating junction temperature | 5962-0720401 |     | 125 | °C   |
|           |                                | 5962-0720402 |     | 115 |      |

### 7.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |   | DAC5675A-SP | UNIT |
|-------------------------------|---|-------------|------|
|                               |   | HFG (CQFP)  |      |
|                               |   | 52 PINS     |      |
| $R_{\theta JA}$               | Junction-to-free-air thermal resistance <sup>(2)</sup>      | 21.813      | °C/W |
| $R_{\theta JC(bot)}$          | Junction-to-case (bottom) thermal resistance <sup>(3)</sup> | 0.849       | °C/W |
| $R_{\theta JB}$               | Junction-to-board thermal resistance                        | N/A         |      |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter                  | N/A         |      |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter                | N/A         |      |

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).  
 (2) Board mounted, per JESD 51-5 methodology  
 (3) MIL-STD-883 test method 1012

## 7.5 DC Electrical Characteristics (Unchanged After 100 kRad)

over operating junction temperature range, typical values at 25°C,  $AV_{DD} = 3.3$  V,  $DV_{DD} = 3.3$  V,  $I_{O(FS)} = 20$  mA (unless otherwise noted)

| PARAMETER                        |   | TEST CONDITIONS                                   | 5962-0720401        |      |                 | 5962-0720402        |      |                 | UNIT          |
|----------------------------------|---|---|---------------------|------|-----------------|---------------------|------|-----------------|---------------|
|                                  |   |   | MIN                 | TYP  | MAX             | MIN                 | TYP  | MAX             |               |
| Resolution                       |   |   | 14                  |      |                 | 14                  |      |                 | bit           |
| <b>DC ACCURACY<sup>(1)</sup></b> |   |   |                     |      |                 |                     |      |                 |               |
| INL                              | Integral nonlinearity                   | $T_{MIN}$ to $T_{MAX}$                            | -4                  | ±1.5 | 4.6             | -4                  | ±1.5 | 4.6             | LSB           |
| DNL                              | Differential nonlinearity               | $T_{25^{\circ}C}$ to $T_{MAX}$                    | -2                  | ±0.6 | 2.2             | -2                  | ±0.6 | 2.2             | LSB           |
|                                  |   | $T_{MIN}$   | -2                  | ±0.6 | 2.5             | -2                  | ±0.6 | 2.5             | LSB           |
| Monotonicity                     |   |   | Monotonic 12b level |      |                 | Monotonic 12b level |      |                 |               |
| <b>ANALOG OUTPUT</b>             |   |   |                     |      |                 |                     |      |                 |               |
| $I_{O(FS)}$                      | Full-scale output current               |   | 2                   |      | 20              | 2                   |      | 20              | mA            |
|                                  | Output compliance range                 | $AV_{DD} = 3.15$ to $3.45$ V, $I_{O(FS)} = 20$ mA | $AV_{DD} - 1$       |      | $AV_{DD} + 0.3$ | $AV_{DD} - 1$       |      | $AV_{DD} + 0.3$ | V             |
|                                  | Offset error                            |   | 0.01                |      |                 | 0.01                |      |                 | %FSR          |
|                                  | Gain error                              | Without internal reference                        | -10                 | 5    | 10              | -10                 | 5    | 10              | %FSR          |
|                                  |   | With internal reference                           | -10                 | 2.5  | 10              | -10                 | 2.5  | 10              | %FSR          |
|                                  | Output resistance                       |   | 300                 |      |                 | 300                 |      |                 | kΩ            |
|                                  | Output capacitance                      |   | 5                   |      |                 | 5                   |      |                 | pF            |
| <b>REFERENCE OUTPUT</b>          |   |   |                     |      |                 |                     |      |                 |               |
| $V_{(EXTIO)}$                    | Reference voltage                       |   | 1.17                | 1.23 | 1.3             | 1.17                | 1.23 | 1.3             | V             |
|                                  | Reference output current <sup>(2)</sup> |   | 100                 |      |                 | 100                 |      |                 | nA            |
| <b>REFERENCE INPUT</b>           |   |   |                     |      |                 |                     |      |                 |               |
| $V_{(EXTIO)}$                    | Input reference voltage                 |   | 0.6                 | 1.2  | 1.25            | 0.6                 | 1.2  | 1.25            | V             |
|                                  | Input resistance                        |   | 1                   |      |                 | 1                   |      |                 | MΩ            |
|                                  | Small-signal bandwidth                  |   | 1.4                 |      |                 | 1.4                 |      |                 | MHz           |
|                                  | Input capacitance                       |   | 100                 |      |                 | 100                 |      |                 | pF            |
| <b>TEMPERATURE COEFFICIENTS</b>  |   |   |                     |      |                 |                     |      |                 |               |
|                                  | Offset drift                            |   | 12                  |      |                 | 12                  |      |                 | ppm of FSR/°C |
| $\Delta V_{(EXTIO)}$             | Reference voltage drift                 |   | ±50                 |      |                 | ±50                 |      |                 | ppm/°C        |
| <b>POWER SUPPLY</b>              |   |   |                     |      |                 |                     |      |                 |               |
| $AV_{DD}$                        | Analog supply voltage                   |   | 3.15                | 3.3  | 3.6             | 3.15                | 3.3  | 3.6             | V             |
| $DV_{DD}$                        | Digital supply voltage                  |   | 3.15                | 3.3  | 3.6             | 3.15                | 3.3  | 3.6             | V             |
| $I_{(AVDD)}$                     | Analog supply current <sup>(3)</sup>    |   | 115                 |      | 148             | 115                 |      | 138             | mA            |

(1) Measured differential at  $I_{OUT1}$  and  $I_{OUT2}$ : 25 Ω to  $AV_{DD}$ .

(2) Use an external buffer amplifier with high impedance input to drive any external load.

(3) Measured at  $f_{CLK} = 400$  MSPS and  $f_{OUT} = 70$  MHz.

**DC Electrical Characteristics (Unchanged After 100 kRad) (continued)**

over operating junction temperature range, typical values at 25°C,  $AV_{DD} = 3.3\text{ V}$ ,  $DV_{DD} = 3.3\text{ V}$ ,  $I_{O(FS)} = 20\text{ mA}$  (unless otherwise noted)

| PARAMETER    |   | TEST CONDITIONS                                     | 5962-0720401 |      |     | 5962-0720402 |      |     | UNIT   |
|--------------|---|---|--------------|------|-----|--------------|------|-----|--------|
|              |   |   | MIN          | TYP  | MAX | MIN          | TYP  | MAX |        |
| $I_{(DVDD)}$ | Digital supply current <sup>(3)</sup>           |   |              | 85   | 130 |              | 85   | 120 | mA     |
| $P_D$        | Power dissipation                               | Sleep mode  |              | 18   |     |              | 18   |     | mW     |
|              |   | $AV_{DD} = 3.3\text{ V}$ , $DV_{DD} = 3.3\text{ V}$ |              | 660  | 900 |              | 660  | 850 | mW     |
| APSRR        | Analog and digital power-supply rejection ratio | $AV_{DD} = 3.15\text{ to }3.45\text{ V}$            | -0.9         | ±0.1 | 0.9 | -0.9         | ±0.1 | 0.9 | %FSR/V |
| DPSRR        |   |   | -0.9         | ±0.1 | 0.9 | -0.9         | ±0.1 | 0.9 |        |

## 7.6 AC Electrical Characteristics (Unchanged After 100 kRad)

over operating junction temperature range, typical values at 25°C,  $V_{DD} = 3.3\text{ V}$ ,  $DV_{DD} = 3.3\text{ V}$ ,  $I_{O(FS)} = 20\text{ mA}$ , differential transformer-coupled output, 50-Ω doubly-terminated load (unless otherwise noted)

| PARAMETER                  | TEST CONDITIONS  | 5962-0720401   |   |     | 5962-0720402 |     |     | UNIT   |     |
|----------------------------|--|--|---|-----|--------------|-----|-----|--------|-----|
|                            |  | MIN  | TYP                                     | MAX | MIN          | TYP | MAX |        |     |
| <b>ANALOG OUTPUT</b>       |  |  |   |     |              |     |     |        |     |
| $f_{CLK}$                  | Output update rate   |  |   | 400 |              |     | 400 | MSPS   |     |
| $t_{s(DAC)}$               | Output setting time to 0.1%  | Transition: code x2000 to x23FF  |   |     |              | 12  |     | ns     |     |
| $t_{PD}$                   | Output propagation delay   |  | 1                                       |     |              | 1   |     | ns     |     |
| $t_{r(IOUT)}$              | Output rise time, 10% to 90%   |  | 300                                     |     |              | 300 |     | ps     |     |
| $t_{f(IOUT)}$              | Output fall time, 90% to 10%   |  | 300                                     |     |              | 300 |     | ps     |     |
| Output noise               | $I_{OUTFS} = 20\text{ mA}$   |  | 55                                      |     |              | 55  |     | pA/√Hz |     |
|                            | $I_{OUTFS} = 2\text{ mA}$  |  | 30                                      |     |              | 30  |     |        |     |
| <b>AC LINEARITY</b>        |  |  |   |     |              |     |     |        |     |
| THD                        | Total harmonic distortion  | $f_{CLK} = 100\text{ MSPS}, f_{OUT} = 19.9\text{ MHz}$                                 |   |     | 70           |     | 70  | dBc    |     |
|                            |  | $f_{CLK} = 160\text{ MSPS}, f_{OUT} = 41\text{ MHz}$                                   |   |     | 72           |     | 72  |        |     |
|                            |  | $f_{CLK} = 200\text{ MSPS}, f_{OUT} = 70\text{ MHz}$                                   |   |     | 68           |     | 68  |        |     |
|                            |  | $f_{CLK} = 400\text{ MSPS}$  | $f_{OUT} = 20\text{ MHz}$               |     | 60           | 68  | 62  |        | 68  |
|                            |  |  | $f_{OUT} = 20\text{ MHz, for } T_{MIN}$ |     | 57           |     | 57  |        |     |
|                            |  |  | $f_{OUT} = 70\text{ MHz}$               |     |              | 67  |     |        | 67  |
| $f_{OUT} = 140\text{ MHz}$ |  |  |   | 55  |              | 55  |     |        |     |
| SFDR                       | Spurious-free dynamic range to Nyquist                                     | $f_{CLK} = 100\text{ MSPS}, f_{OUT} = 19.9\text{ MHz}$                                 |   |     | 70           |     | 70  | dBc    |     |
|                            |  | $f_{CLK} = 160\text{ MSPS}, f_{OUT} = 41\text{ MHz}$                                   |   |     | 73           |     | 73  |        |     |
|                            |  | $f_{CLK} = 200\text{ MSPS}, f_{OUT} = 70\text{ MHz}$                                   |   |     | 70           |     | 70  |        |     |
|                            |  | $f_{CLK} = 400\text{ MSPS}$  | $f_{OUT} = 20\text{ MHz}$               |     | 62           | 68  | 63  |        | 68  |
|                            |  |  | $f_{OUT} = 20\text{ MHz, for } T_{MIN}$ |     | 61           |     | 61  |        |     |
|                            |  |  | $f_{OUT} = 70\text{ MHz}$               |     |              | 69  |     |        | 69  |
| $f_{OUT} = 140\text{ MHz}$ |  |  |   | 56  |              | 56  |     |        |     |
| SFDR                       | Spurious-free dynamic range within a window, 5 MHz span                    | $f_{CLK} = 100\text{ MSPS}, f_{OUT} = 19.9\text{ MHz}$                                 |   |     | 82           |     | 82  | dBc    |     |
|                            |  | $f_{CLK} = 160\text{ MSPS}, f_{OUT} = 41\text{ MHz}$                                   |   |     | 77           |     | 77  |        |     |
|                            |  | $f_{CLK} = 200\text{ MSPS}, f_{OUT} = 70\text{ MHz}$                                   |   |     | 82           |     | 82  |        |     |
|                            |  | $f_{CLK} = 400\text{ MSPS}$  | $f_{OUT} = 20\text{ MHz}$               |     | 82           |     | 82  |        |     |
|                            |  |  | $f_{OUT} = 70\text{ MHz}$               |     |              | 82  |     |        | 82  |
|                            |  |  | $f_{OUT} = 140\text{ MHz}$              |     |              | 75  |     |        | 75  |
| SNR                        | Signal-to-noise ratio  | $f_{CLK} = 400\text{ MSPS}, f_{OUT} = 20\text{ MHz}$                                   |   |     | 60           | 67  | 60  | 67     | dBc |
| ACPR                       | Adjacent channel power ratio WCDMA with 3.84 MHz BW, 5 MHz channel spacing | $f_{CLK} = 122.88\text{ MSPS}, IF = 30.72\text{ MHz}$ , see <a href="#">Figure 9</a>   |   |     |              | 73  |     | 73     | dB  |
|                            |  | $f_{CLK} = 245.76\text{ MSPS}, IF = 61.44\text{ MHz}$ ,                                |   |     |              | 71  |     | 71     |     |
|                            |  | $f_{CLK} = 399.36\text{ MSPS}, IF = 153.36\text{ MHz}$ , see <a href="#">Figure 11</a> |   |     |              | 65  |     | 65     |     |



**AC Electrical Characteristics (Unchanged After 100 kRad) (continued)**

over operating junction temperature range, typical values at 25°C,  $AV_{DD} = 3.3$  V,  $DV_{DD} = 3.3$  V,  $I_{O(FS)} = 20$  mA, differential transformer-coupled output, 50-Ω doubly-terminated load (unless otherwise noted)

| PARAMETER |   | TEST CONDITIONS  | 5962-0720401 |     |     | 5962-0720402 |     |     | UNIT |
|-----------|---|--|--------------|-----|-----|--------------|-----|-----|------|
|           |   |  | MIN          | TYP | MAX | MIN          | TYP | MAX |      |
| IMD       | Two-tone intermodulation to Nyquist (each tone at -6 dBfs)                          | $f_{CLK} = 400$ MSPS, $f_{OUT1} = 70$ MHz, $f_{OUT2} = 71$ MHz   |              | 73  |     |              | 73  |     | dBc  |
|           |   | $f_{CLK} = 400$ MSPS, $f_{OUT1} = 140$ MHz, $f_{OUT2} = 141$ MHz |              | 62  |     |              | 62  |     |      |
|           | Four-tone intermodulation, 15-MHz span, missing center tone (each tone at -16 dBfs) | $f_{CLK} = 156$ MSPS, $f_{OUT} = 15.6, 15.8, 16.2, 16.4$ MHz     |              | 82  |     |              | 82  |     |      |
|           |   | $f_{CLK} = 400$ MSPS, $f_{OUT} = 68.1, 69.3, 71.2, 72$ MHz       |              | 74  |     |              | 74  |     |      |

### 7.7 Digital Specifications (Unchanged After 100 kRad)

over operating junction temperature range, typical values at 25°C,  $AV_{DD} = 3.3\text{ V}$ ,  $DV_{DD} = 3.3\text{ V}$  (unless otherwise noted)

| PARAMETER                                       | TEST CONDITIONS                                     | 5962-0720401   |      |     | 5962-0720402   |     |     | UNIT          |
|---|---|----------------|------|-----|----------------|-----|-----|---------------|
|   |   | MIN            | TYP  | MAX | MIN            | TYP | MAX |               |
| <b>LVDS INTERFACE: NODES D[13:0]A, D[13:0]B</b> |   |                |      |     |                |     |     |               |
| $V_{ITH+}$                                      | Positive-going differential input voltage threshold |                | 100  |     | 100            |     |     | mV            |
| $V_{ITH-}$                                      | Negative-going differential input voltage threshold |                | -100 |     | -100           |     |     | mV            |
| $Z_T$   | Internal termination impedance                      | 90             | 110  | 132 | 90             | 110 | 132 | $\Omega$      |
| $C_I$   | Input capacitance                                   |                | 2    |     | 2              |     |     | pF            |
| <b>CMOS INTERFACE (SLEEP)</b>                   |   |                |      |     |                |     |     |               |
| $V_{IH}$  | High-level input voltage                            | 2              | 3.3  |     | 2              | 3.3 |     | V             |
| $V_{IL}$  | Low-level input voltage                             |                | 0    | 0.8 |                | 0   | 0.8 | V             |
| $I_{IH}$  | High-level input current                            | 10             |      | 100 | 10             |     | 100 | $\mu\text{A}$ |
| $I_{IL}$  | Low-level input current                             | -10            |      | 10  | -10            |     | 10  | $\mu\text{A}$ |
|   | Input capacitance                                   |                | 2    |     | 2              |     |     | pF            |
| <b>CLOCK INTERFACE (CLK, CLKC)</b>              |   |                |      |     |                |     |     |               |
| $ \text{CLK-CLKC} $                             | Clock differential input voltage                    | 0.4            |      | 0.8 | 0.4            |     | 0.8 | $V_{PP}$      |
| $t_{w(H)}$                                      | Clock pulse width high                              |                | 1.25 |     | 1.25           |     |     | ns            |
| $t_{w(L)}$                                      | Clock pulse width low                               |                | 1.25 |     | 1.25           |     |     | ns            |
|   | Clock duty cycle                                    | 40%            |      | 60% | 40%            |     | 60% |               |
| $V_{CM}$  | Common-mode voltage range                           | 1.6            | 2    | 2.4 | 1.6            | 2   | 2.4 | V             |
|   | Input resistance                                    | Node CLK, CLKC |      | 670 | Node CLK, CLKC |     | 670 | $\Omega$      |
|   | Input capacitance                                   | Node CLK, CLKC |      | 2   | Node CLK, CLKC |     | 2   | pF            |
|   | Input resistance                                    | Differential   |      | 1.3 | Differential   |     | 1.3 | k $\Omega$    |
|   | Input capacitance                                   | Differential   |      | 1   | Differential   |     | 1   | pF            |
| <b>TIMING</b>                                   |   |                |      |     |                |     |     |               |
| $t_{SU}$  | Input setup time                                    |                | 1.5  |     | 1.5            |     |     | ns            |
| $t_H$   | Input hold time                                     |                | 0    |     | 0              |     |     | ns            |
| $t_{DD}$  | Digital delay time (DAC latency)                    |                |      | 3   |                |     | 3   | clk           |

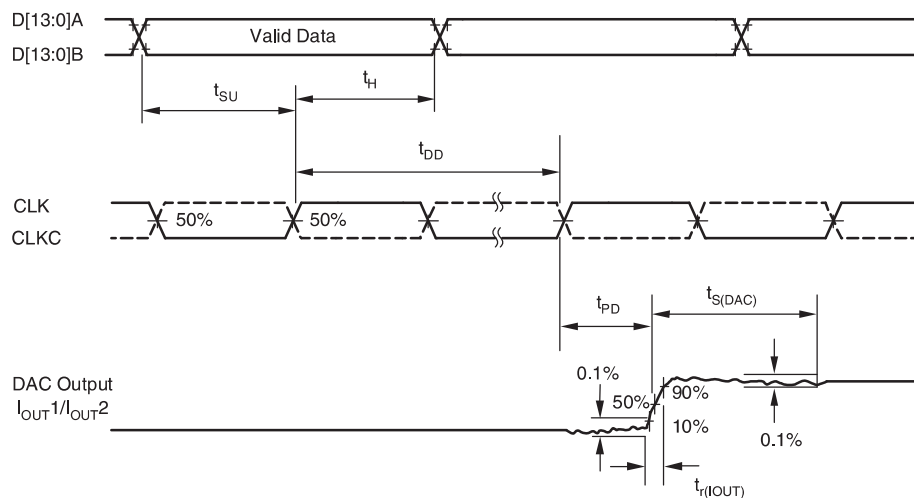


Figure 1. Timing Diagram

### 7.8 Electrical Characteristics<sup>(1)</sup>

over operating junction temperature range,  $AV_{DD} = 3.3\text{ V}$ ,  $DV_{DD} = 3.3\text{ V}$ ,  $I_{O(FS)} = 20\text{ mA}$  (unless otherwise noted)

| APPLIED VOLTAGES |           | RESULTING DIFFERENTIAL INPUT VOLTAGE | RESULTING COMMON-MODE INPUT VOLTAGE | LOGICAL BIT BINARY EQUIVALENT | COMMENT  |
|------------------|-----------|--------------------------------------|-------------------------------------|-------------------------------|--|
| $V_A$ (V)        | $V_B$ (V) | $V_{A,B}$ (mV)                       | $V_{COM}$ (V)                       |                               |  |
| 1.25             | 1.15      | 100                                  | 1.2                                 | 1                             | Operation with minimum differential voltage ( $\pm 100\text{ mV}$ ) applied to the complementary inputs versus common-mode range |
| 1.15             | 1.25      | -100                                 | 1.2                                 | 0                             |  |
| 2.4              | 2.3       | 100                                  | 2.35                                | 1                             |  |
| 2.3              | 2.4       | -100                                 | 2.35                                | 0                             |  |
| 0.1              | 0         | 100                                  | 0.05                                | 1                             |  |
| 0                | 0.1       | -100                                 | 0.05                                | 0                             |  |
| 1.5              | 0.9       | 600                                  | 1.2                                 | 1                             | Operation with maximum differential voltage ( $\pm 600\text{ mV}$ ) applied to the complementary inputs versus common-mode range |
| 0.9              | 1.5       | -600                                 | 1.2                                 | 0                             |  |
| 2.4              | 1.8       | 600                                  | 2.1                                 | 1                             |  |
| 1.8              | 2.4       | -600                                 | 2.1                                 | 0                             |  |
| 0.6              | 0         | 600                                  | 0.3                                 | 1                             |  |
| 0                | 0.6       | -600                                 | 0.3                                 | 0                             |  |

(1) Specifications subject to change.

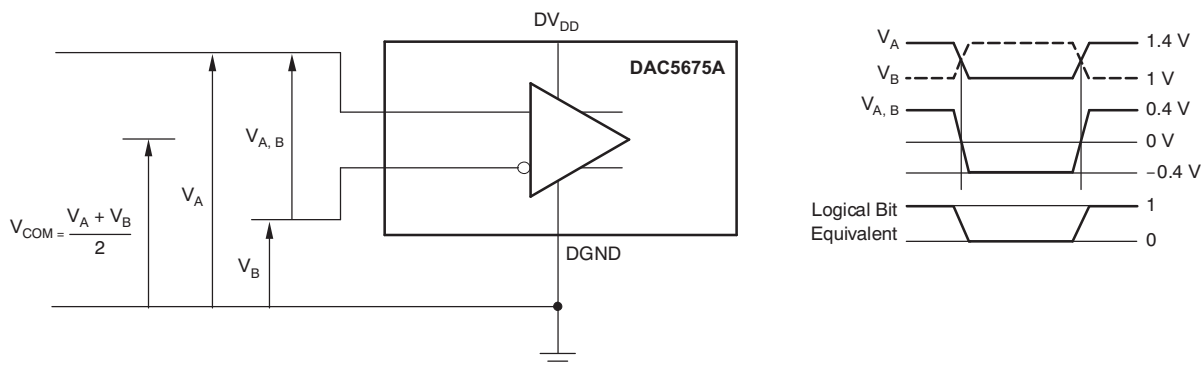


Figure 2. LVDS Timing Test Circuit and Input Test Levels

### 7.9 Typical Characteristics

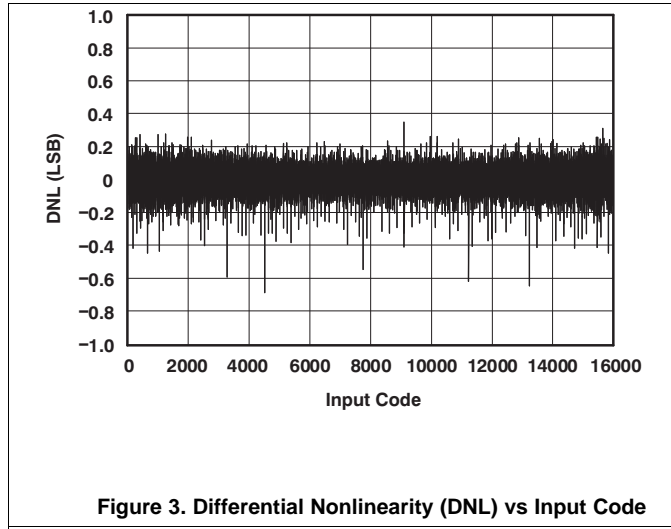


Figure 3. Differential Nonlinearity (DNL) vs Input Code

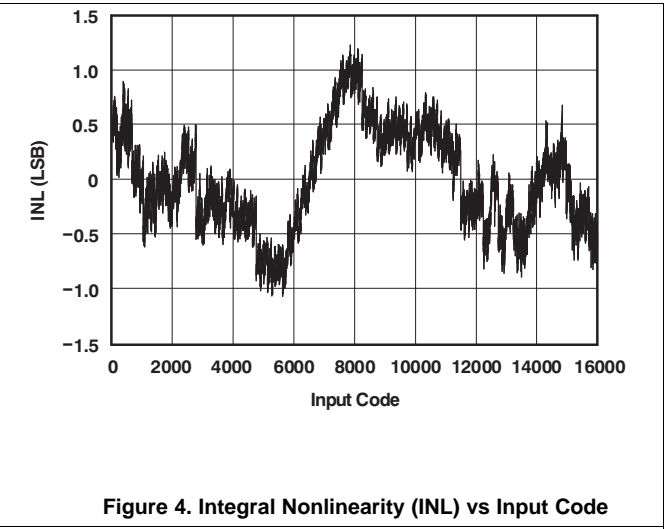


Figure 4. Integral Nonlinearity (INL) vs Input Code

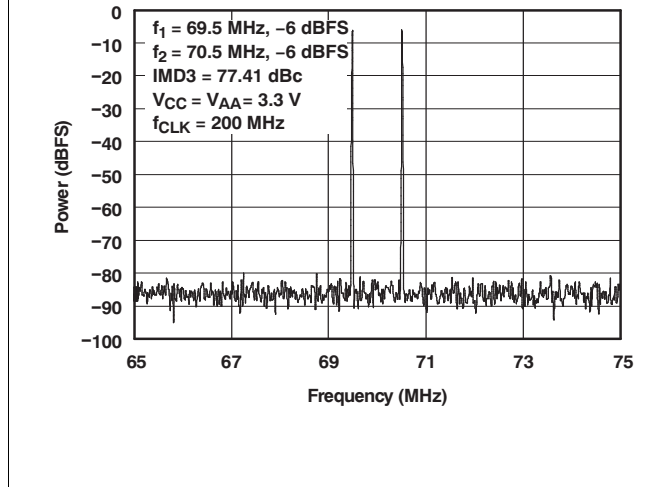


Figure 5. Two-Tone IMD (Power) vs Frequency

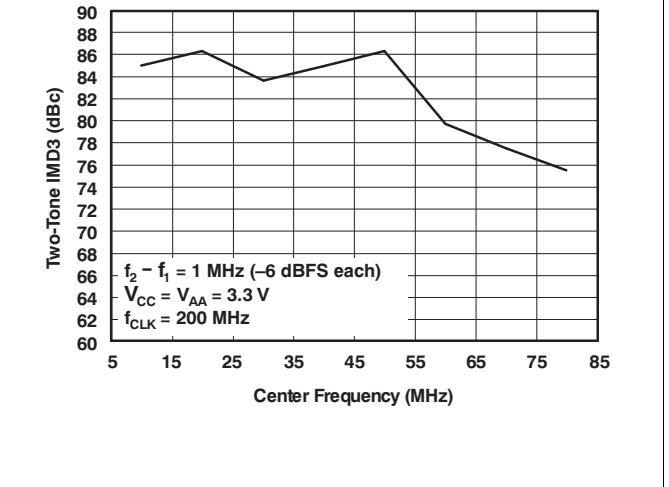


Figure 6. Two-Tone IMD3 vs Frequency

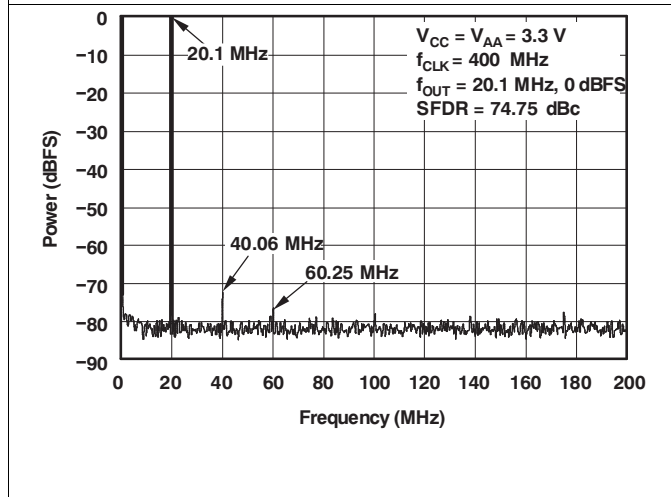


Figure 7. Single-Tone Spectrum Power vs Frequency

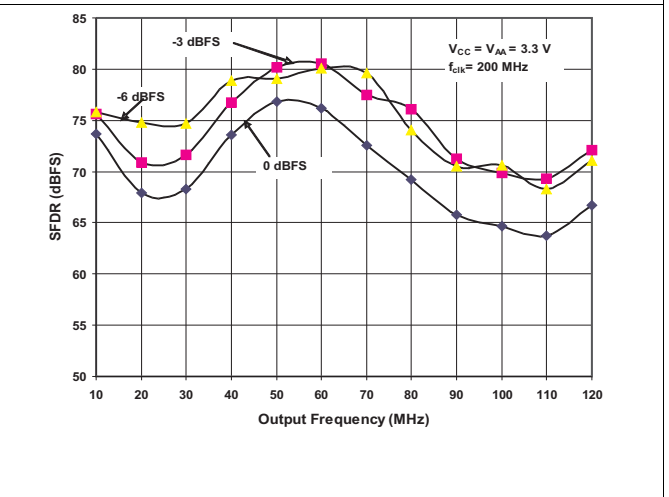


Figure 8. Spurious-Free Dynamic Range vs Frequency

Typical Characteristics (continued)

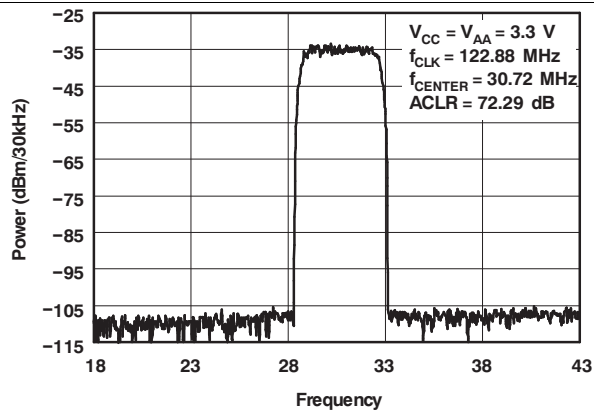


Figure 9. W-CDMA TM1 Single Carrier Power vs Frequency

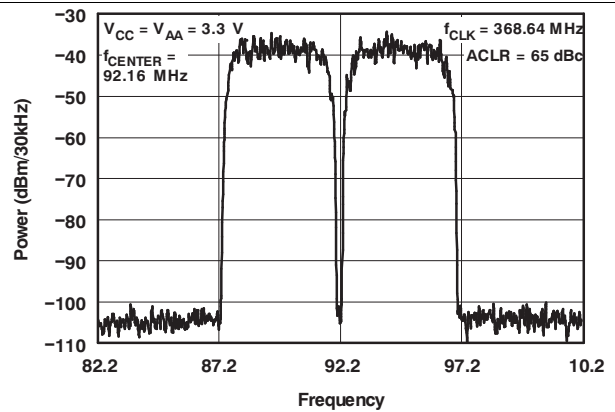


Figure 10. W-CDMA TM1 Dual Carrier Power vs Frequency

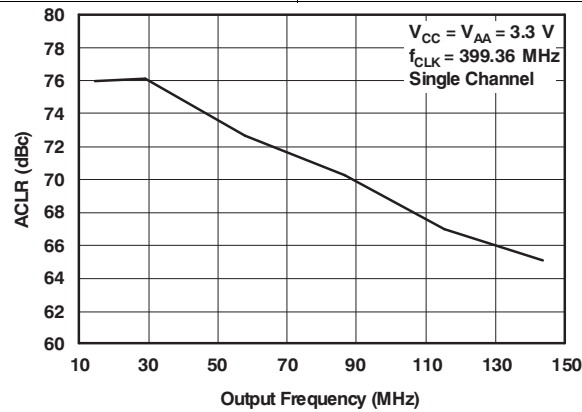


Figure 11. W-CDMA TM1 Single Carrier ACLR vs Output Frequency

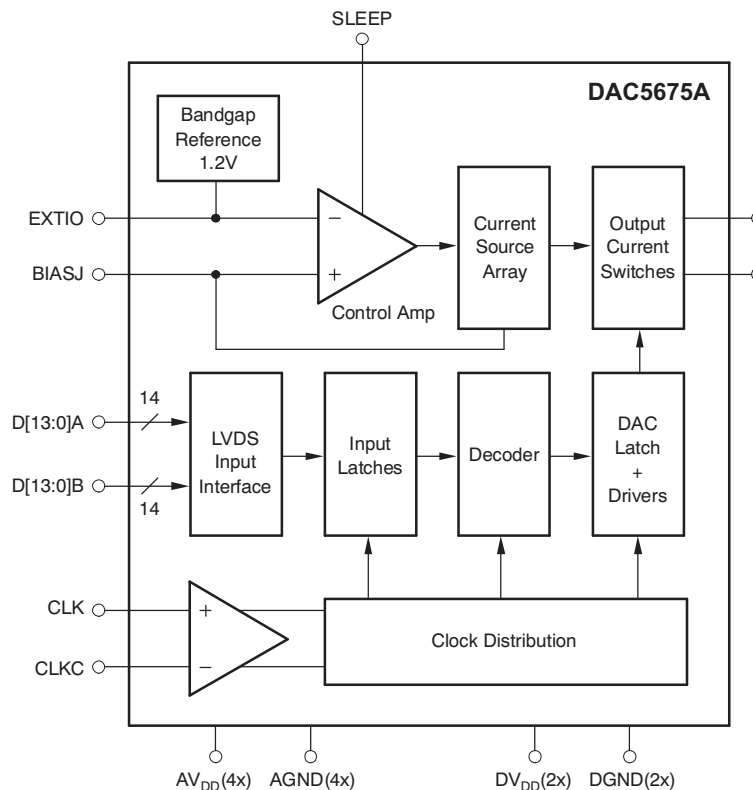
## 8 Detailed Description

### 8.1 Overview

*Functional Block Diagram* shows a simplified block diagram of the current steering DAC5675A-SP. The DAC5675A-SP consists of a segmented array of NPN-transistor current sources, capable of delivering a full-scale output current up to 20 mA. Differential current switches direct the current of each current source to either one of the complementary output nodes IOUT1 or IOUT2. The complementary current output enables differential operation, canceling out common-mode noise sources (digital feedthrough, on-chip, and PCB noise), dc offsets, and even-order distortion components, and doubling signal output power.

The full-scale output current is set using an external resistor ( $R_{BIAS}$ ) with an on-chip bandgap voltage reference source (1.2 V) and control amplifier. The current ( $I_{BIAS}$ ) through resistor  $R_{BIAS}$  is mirrored internally to provide a full-scale output current equal to  $16 \times I_{BIAS}$ . The full-scale current is adjustable from 20 to 2 mA by using the appropriate bias resistor value.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 Digital Inputs

The DAC5675A-SP uses a low-voltage differential signaling (LVDS) bus input interface. The LVDS features a low differential voltage swing with low constant power consumption (4 mA per complementary data input) across frequency. The differential characteristic of LVDS allows for high-speed data transmission with low electromagnetic interference (EMI) levels. Figure 12 shows the equivalent complementary digital input interface for the DAC5675A-SP, valid for pins D[13:0]A and D[13:0]B. Note that the LVDS interface features internal 110-Ω resistors for proper termination. Figure 2 shows the LVDS input timing measurement circuit and waveforms. A common-mode level of 1.2 V and a differential input swing of 0.8 V<sub>PP</sub> is applied to the inputs.

Figure 13 shows a schematic of the equivalent CMOS/TTL-compatible digital inputs of the DAC5675A-SP, valid for the SLEEP pin.

Feature Description (continued)

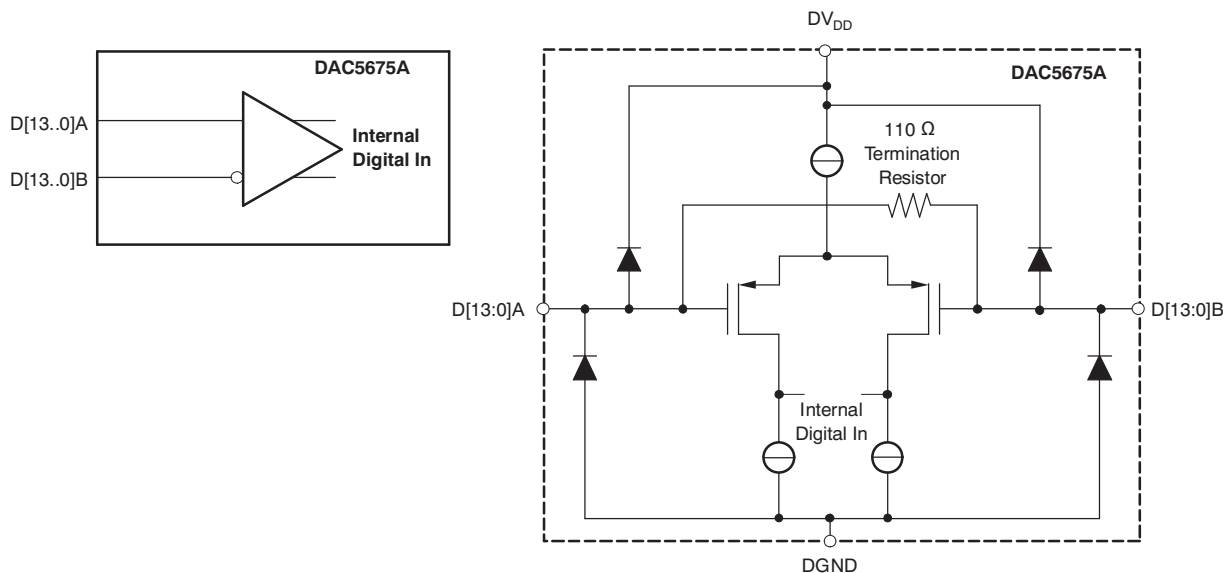


Figure 12. LVDS Digital Equivalent Input

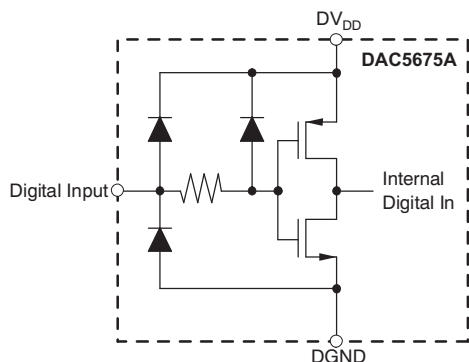


Figure 13. CMOS/TTL Digital Equivalent Input

8.3.2 Clock Input

The DAC5675A-SP features differential LVPECL-compatible clock inputs (CLK, CLKC). Figure 14 shows the equivalent schematic of the clock input buffer. The internal biasing resistors set the input common-mode voltage to approximately 2 V, while the input resistance is typically 670 Ω. A variety of clock sources can be ac-coupled to the device, including a sine-wave source (see Figure 15).

Feature Description (continued)

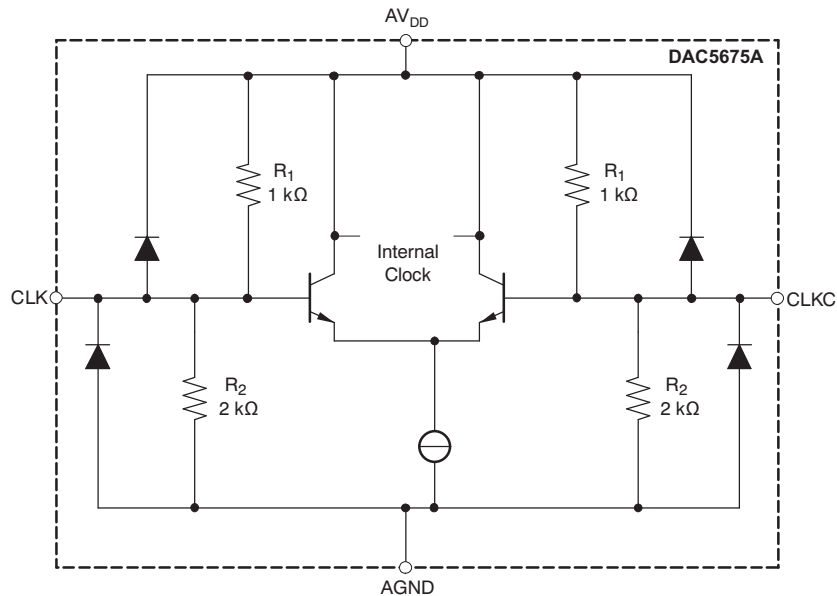


Figure 14. Clock Equivalent Input

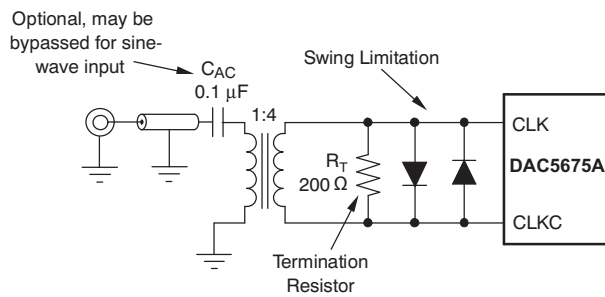


Figure 15. Driving the DAC5675A-SP With a Single-Ended Clock Source Using a Transformer

To obtain best ac performance, the DAC5675A-SP clock input should be driven with a differential LVPECL or sine-wave source as shown in Figure 16 and Figure 17. Here, the potential of  $V_{TT}$  should be set to the termination voltage required by the driver along with the proper termination resistors ( $R_T$ ). The DAC5675A-SP clock input can also be driven single ended (see Figure 18).

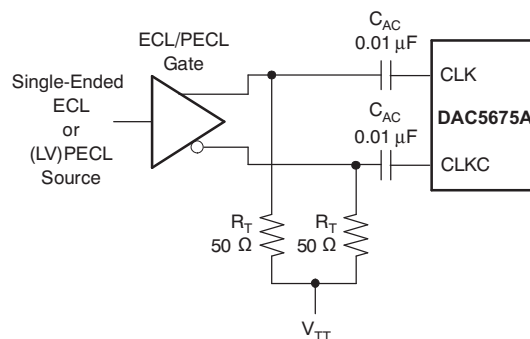


Figure 16. Driving the DAC5675A-SP With a Single-Ended ECL/PECL Clock Source



## Feature Description (continued)

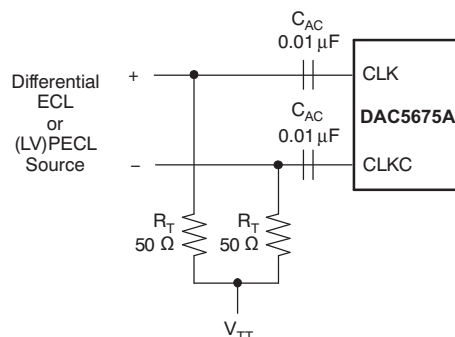


Figure 17. Driving the DAC5675A-SP With a Differential ECL/PECL Clock Source

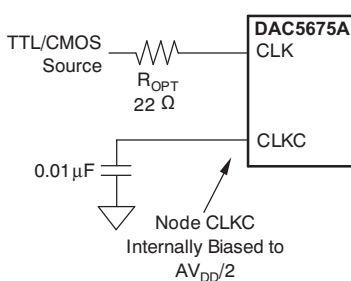


Figure 18. Driving the DAC5675A-SP With a Single-Ended TTL/CMOS Clock Source

### 8.3.3 Supply Inputs

The DAC5675A-SP comprises separate analog and digital supplies,  $AV_{DD}$  and  $DV_{DD}$ , respectively. These supply inputs can be set independently from 3.6 to 3.15 V.

### 8.3.4 DAC Transfer Function

The DAC5675A-SP has a current sink output. The current flow through IOUT1 and IOUT2 is controlled by  $D[13:0]A$  and  $D[13:0]B$ . For ease of use,  $D[13:0]$  is denoted as the logical bit equivalent of  $D[13:0]A$  and its complement  $D[13:0]B$ . The DAC5675A-SP supports straight binary coding with D13 being the MSB and D0 the LSB. Full-scale current flows through IOUT2 when all  $D[13:0]$  inputs are set high and through IOUT1 when all  $D[13:0]$  inputs are set low. The relationship between IOUT1 and IOUT2 can be expressed as [Equation 1](#).

$$I_{OUT1} = I_{O(FS)} - I_{OUT2} \quad (1)$$

$I_{O(FS)}$  is the full-scale output current sink (2 to 20 mA). Because the output stage is a current sink, the current can only flow from  $AV_{DD}$  through the load resistors  $R_L$  into the IOUT1 and IOUT2 pins.

The output current flow in each pin driving a resistive load can be expressed as shown in [Figure 19](#), [Equation 2](#), and [Equation 3](#).

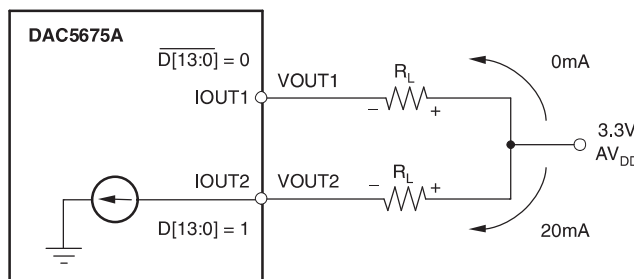


Figure 19. Relationship Between  $D[13:0]$ , IOUT1 and IOUT2

## Feature Description (continued)

$$I_{OUT1} = \frac{I_{O(FS)} \times (16383 - \text{CODE})}{16384} \quad (2)$$

$$I_{OUT2} = \frac{I_{O(FS)} \times \text{CODE}}{16384}$$

where

- CODE is the decimal representation of the DAC input word (3)

This would translate into single-ended voltages at IOUT1 and IOUT2, as shown in [Equation 4](#) and [Equation 5](#).

$$V_{OUT1} = AV_{DD} - I_{OUT1} \times R_L \quad (4)$$

$$V_{OUT2} = AV_{DD} - I_{OUT2} \times R_L \quad (5)$$

Assuming that D[13:0] = 1 and the  $R_L$  is 50  $\Omega$ , the differential voltage between pins IOUT1 and IOUT2 can be expressed as shown in [Equation 6](#) through [Equation 8](#).

$$V_{OUT1} = 3.3 \text{ V} - 0 \text{ mA} \times 50 = 3.3 \text{ V} \quad (6)$$

$$V_{OUT2} = AV_{DD} - 20 \text{ mA} \times 50 = 2.3 \text{ V} \quad (7)$$

$$V_{DIFF} = V_{OUT1} - V_{OUT2} = 1 \text{ V} \quad (8)$$

If D[13:0] = 0, then IOUT2 = 0 mA, IOUT1 = 20 mA, and the differential voltage  $V_{DIFF} = -1 \text{ V}$ .

The output currents and voltages in IOUT1 and IOUT2 are complementary. The voltage, when measured differentially, is doubled compared to measuring each output individually. Take care not to exceed the compliance voltages at the IOUT1 and IOUT2 pins to keep signal distortion low.

### 8.3.5 Reference Operation

The DAC5675A-SP has a bandgap reference and control amplifier for biasing the full-scale output current. The full-scale output current is set by applying an external resistor,  $R_{BIAS}$ . The bias current  $I_{BIAS}$  through resistor  $R_{BIAS}$  is defined by the on-chip bandgap reference voltage and control amplifier. The full-scale output current equals 16x this bias current. The full-scale output current  $I_{O(FS)}$  is thus expressed as [Equation 9](#).

$$I_{O(FS)} = 16 \times I_{BIAS} = \frac{16 \times V_{EXTIO}}{R_{BIAS}}$$

where

- $V_{EXTIO}$  is the voltage at pin EXTIO (9)

The bandgap reference voltage delivers a stable voltage of 1.2 V. This reference can be overridden by applying an external voltage to terminal EXTIO. The bandgap reference can additionally be used for external reference operation. In such a case, select an external buffer amplifier with high-impedance input to limit the bandgap load current to less than 100 nA. The capacitor  $C_{EXT}$  may be omitted. Pin EXTIO serves as either an input or output node. The full-scale output current is adjustable from 20 to 2 mA by varying resistor  $R_{BIAS}$ .

### 8.3.6 Analog Current Outputs

[Figure 20](#) shows a simplified schematic of the current source array output with corresponding switches. Differential NPN switches direct the current of each individual NPN current source to either the positive output node IOUT1 or its complementary negative output node IOUT2. The output impedance is determined by the stack of the current sources and differential switches and is >300 k $\Omega$  in parallel with 5-pF output capacitance.

The external output resistors are referred to the positive supply,  $AV_{DD}$ .

Feature Description (continued)

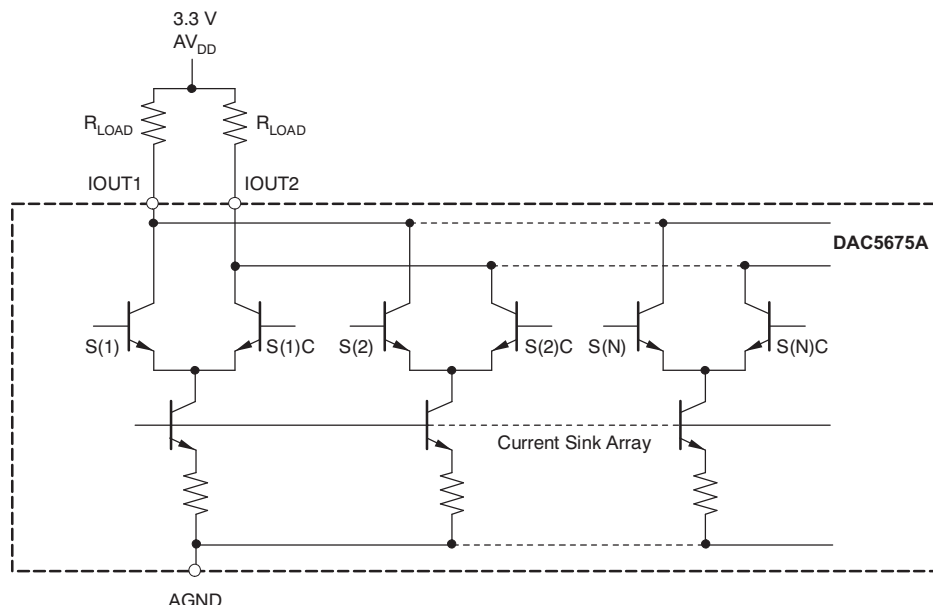


Figure 20. Equivalent Analog Current Output

Figure 21(a) shows the typical differential output configuration with two external matched resistor loads. The nominal resistor load of 25 Ω gives a differential output swing of 1 V<sub>PP</sub> (0.5 V<sub>PP</sub> single ended) when applying a 20-mA full-scale output current. The output impedance of the DAC5675A-SP slightly depends on the output voltage at nodes IOUT1 and IOUT2. Consequently, for optimum dc-integral nonlinearity, choose the configuration of Figure 21(b). In this current/voltage (I-V) configuration, terminal IOUT1 is kept at AV<sub>DD</sub> by the inverting operational amplifier. The complementary output should be connected to AV<sub>DD</sub> to provide a dc-current path for the current sources switched to IOUT1. The amplifier maximum output swing and the full-scale output current of the DAC determine the value of the feedback resistor, R<sub>FB</sub>. The capacitor C<sub>FB</sub> filters the steep edges of the DAC5675A-SP current output, thereby reducing the operational amplifier slew-rate requirements. In this configuration, the operational amplifier should operate at a supply voltage higher than the resistor output reference voltage AV<sub>DD</sub> as a result of its positive and negative output swing around AV<sub>DD</sub>. Select node IOUT1 if a single-ended unipolar output is desired.

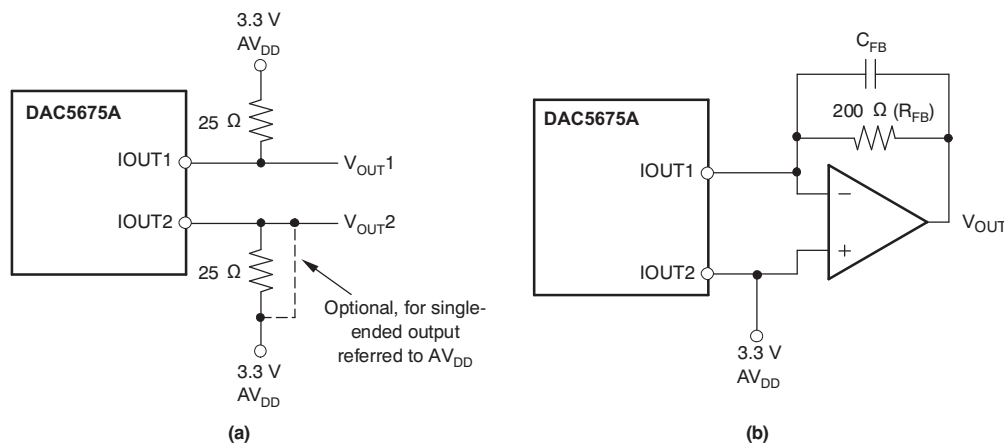


Figure 21. Output Configurations

## 8.4 Device Functional Modes

### 8.4.1 Sleep Mode

The DAC5675A-SP features a power-down mode that turns off the output current and reduces the supply current to approximately 6 mA. The power-down mode is activated by applying a logic level one to the SLEEP pin, pulled down internally.

## 9 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The DAC5675A-SP is a 14-bit resolution high-speed DAC. The DAC5675A-SP is designed for high-speed digital data transmission in wired and wireless communication systems, high-frequency DDS, and waveform reconstruction in test and measurement applications. The DAC5675A-SP has excellent SFDR at high intermediate frequencies, which makes it well suited for multicarrier transmission in TDMA and CDMA based cellular BTSs.

### 9.2 Typical Application

The DAC5675A-SP consists of a segmented array of NPN-transistor current sources, capable of delivering a full-scale output current up to 20 mA. Differential current switches direct the current of each current source to either one of the complementary output nodes IOUT1 or IOUT2. The complementary current output enables differential operation, canceling out common-mode noise sources (digital feed through, on-chip, and PCB noise), dc offsets, and even order distortion components, and doubling signal output power.

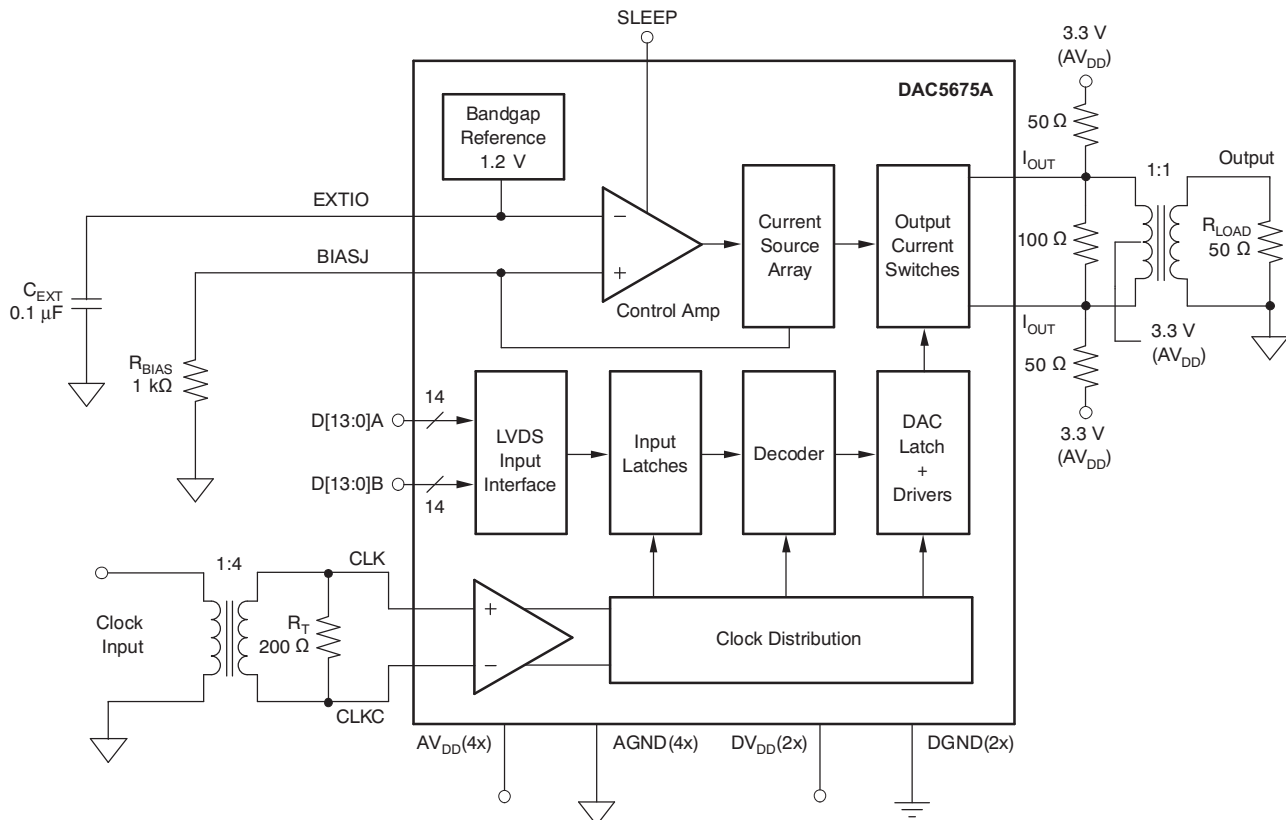


Figure 22. Typical Application Schematic

#### 9.2.1 Design Requirements

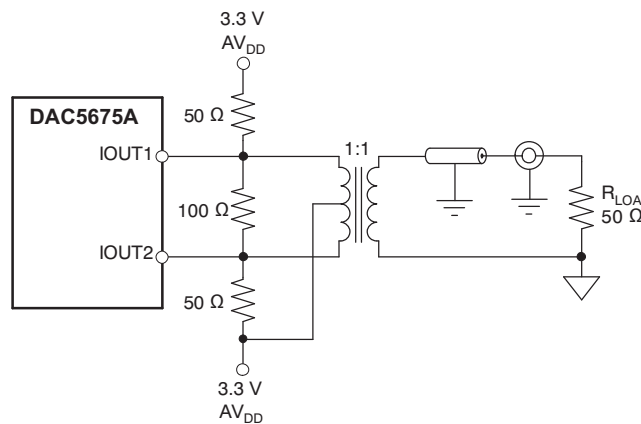
For this design example, use the parameters listed in Table 1 as the input parameters.

**Table 1. Design Parameters**

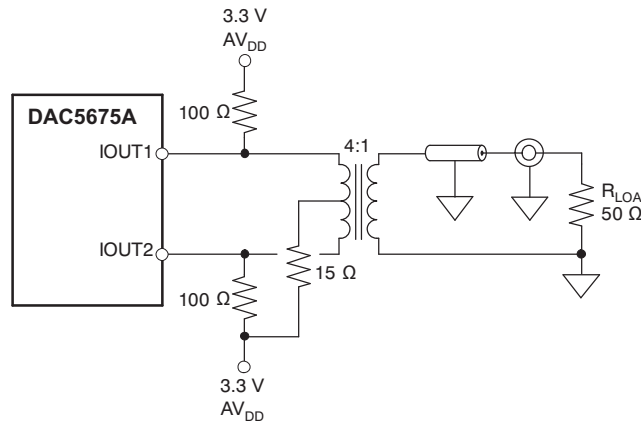
| Design Parameter | Example Value |
|------------------|---------------|
| Cest             | 0.1 $\mu$ F   |
| Rbias            | 1 k $\Omega$  |
| RT               | 200 $\Omega$  |
| Rload            | 50 $\Omega$   |

**9.2.2 Detailed Design Procedure**

The DAC5675A-SP can be easily configured to drive a doubly-terminated 50- $\Omega$  cable using a properly selected transformer. Figure 23 and Figure 24 show the 1:1 and 4:1 impedance ratio configuration, respectively. These configurations provide maximum rejection of common-mode noise sources and even-order distortion components, thereby doubling the power of the DAC to the output. The center tap on the primary side of the transformer is terminated to AV<sub>DD</sub>, enabling a dc-current flow for both IOUT1 and IOUT2. Note that the ac performance of the DAC5675A-SP is optimum and specified using a 1:1 differential transformer-coupled output.

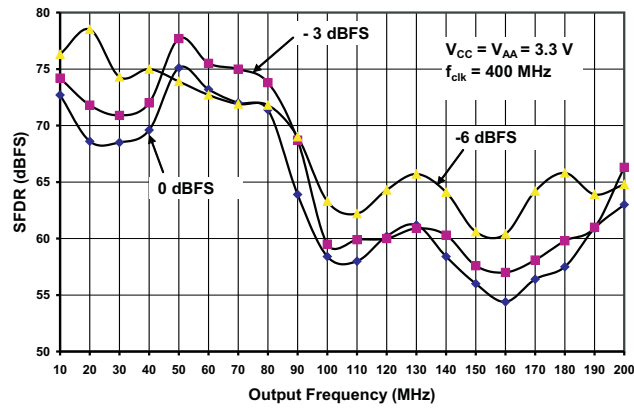


**Figure 23. Driving a Doubly Terminated 50- $\Omega$  Cable Using a 1:1 Impedance Ratio Transformer**



**Figure 24. Driving a Doubly Terminated 50  $\Omega$  Cable Using a 4:1 Impedance Ratio Transformer**

**9.2.3 Application Curve**



**Figure 25. Spurious-Free Dynamic Range vs Frequency**

## 10 Power Supply Recommendations

The DAC5675 uses a single 3.3-V power supply simplifying design requirements. The power supply should be filtered from any other system noise that may be present. The filtering should pay particular attention to frequencies of interest for output.

If  $AV_{DD}$  and  $DV_{DD}$  are powered from separate supplies, it is necessary to ensure that both supplies ramp simultaneously allowing for a maximum  $AV_{DD}$  to  $DV_{DD}$  differential of  $-0.7\text{ V}$  to  $+0.7\text{ V}$  to avoid stress on ESD protection diodes.

## 11 Layout

### 11.1 Layout Guidelines

- DAC output termination should be placed as close as possible to outputs.
- Keep routing for RBIAS short.
- Decoupling capacitors should be placed as close as possible to supply pins.
- Digital differential inputs must be  $50\ \Omega$  to ground loosely coupled, or  $100\text{-}\Omega$  differential tightly coupled.
- Digital differential inputs must be length matched.

### 11.2 Layout Example

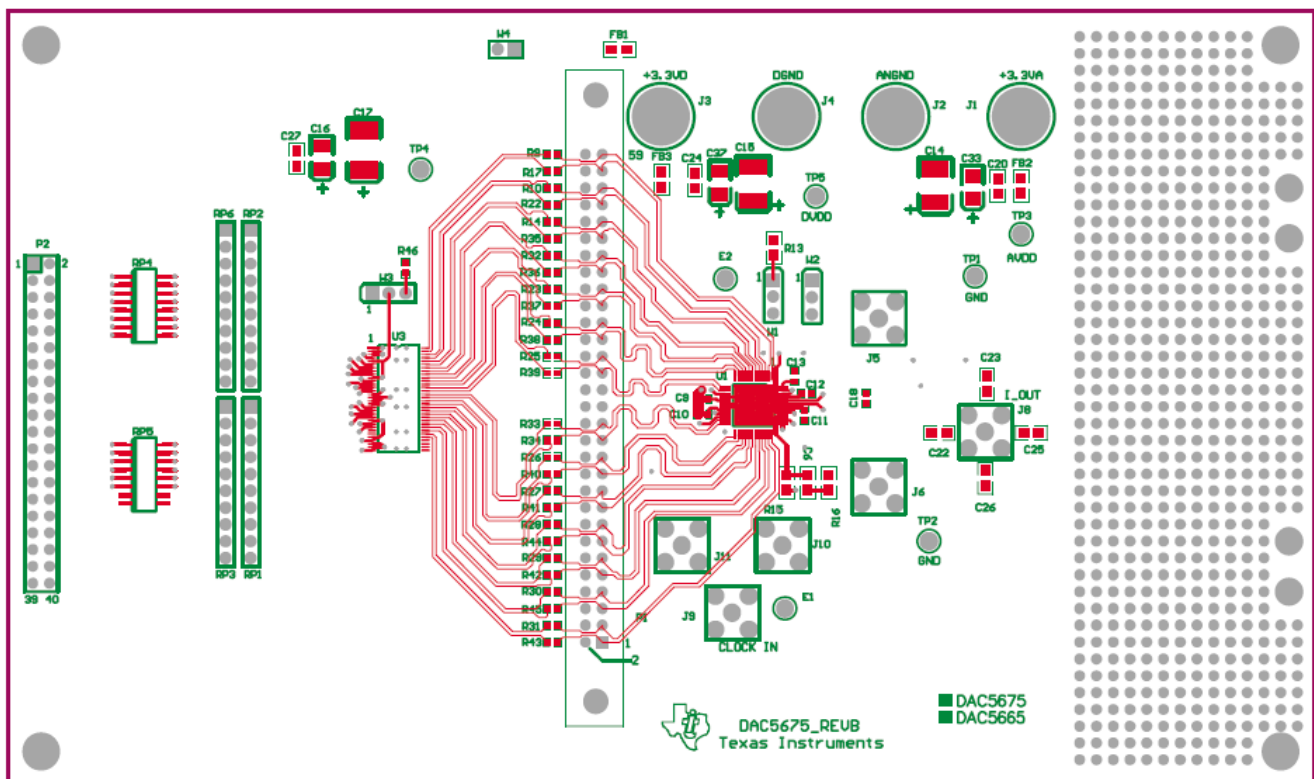


Figure 26. Top Layer



## Layout Example (continued)

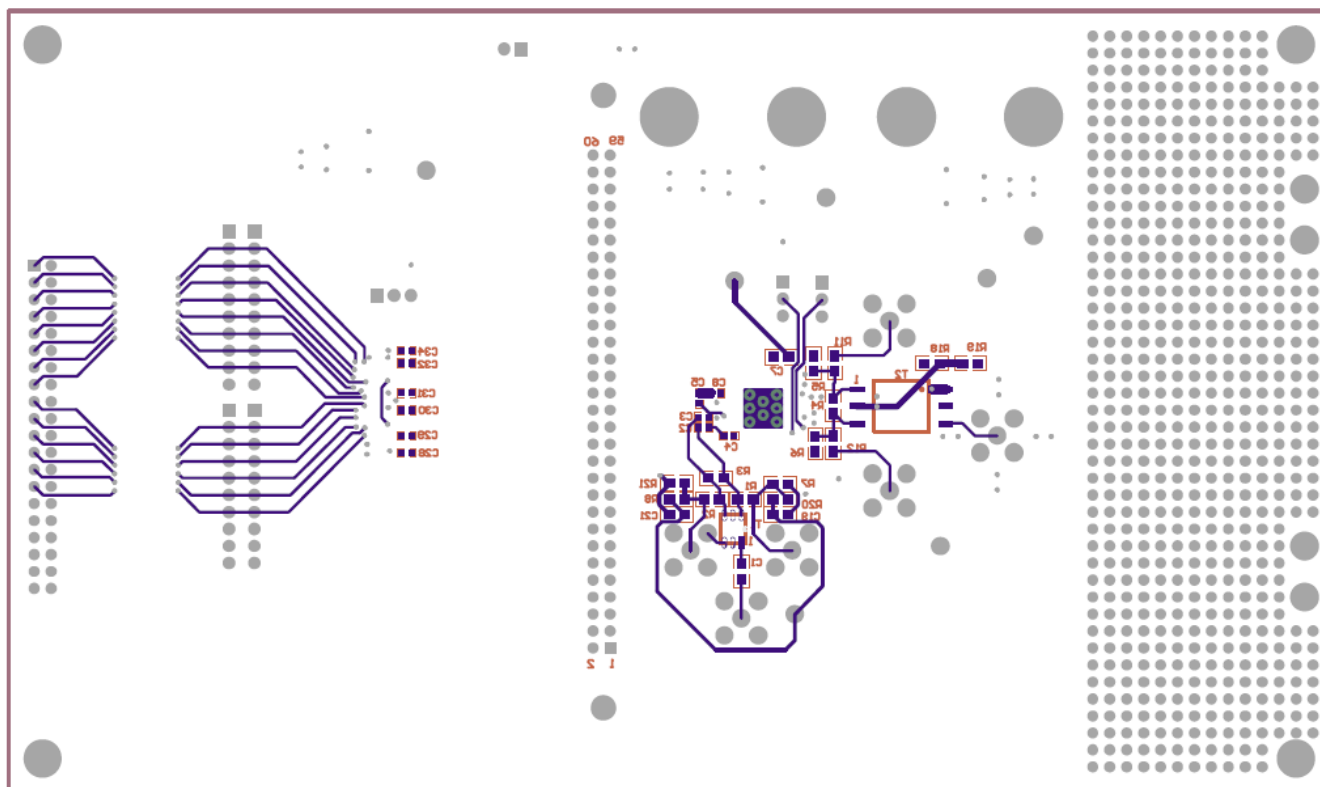
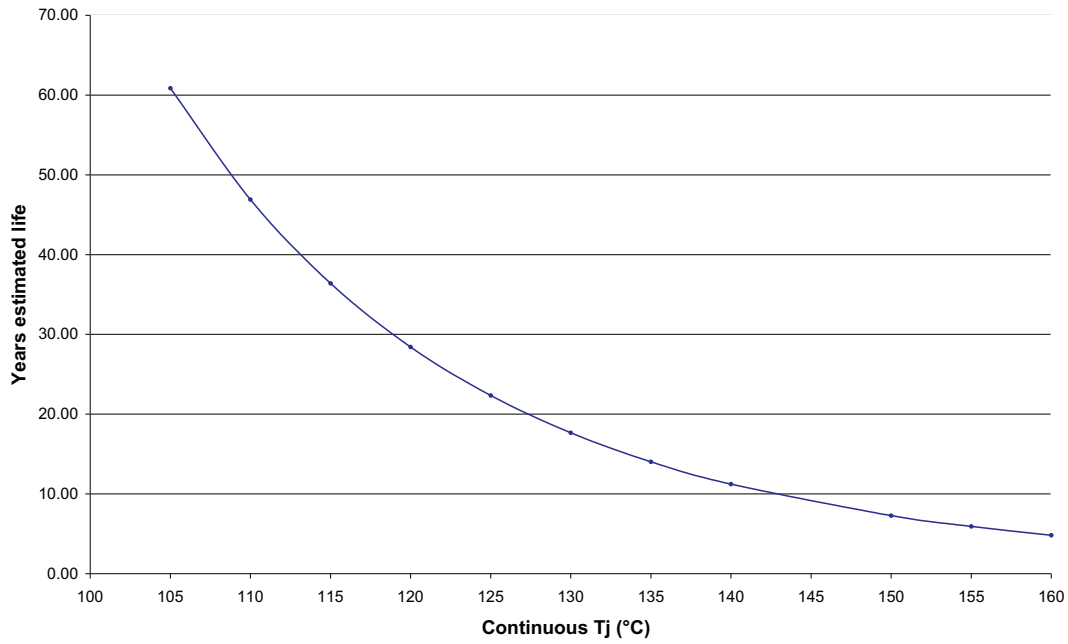


Figure 27. Bottom Layer

### 11.3 Thermal Considerations

This CQFP package has built-in vias that electrically and thermally connect the bottom of the die to a pad on the bottom of the package. To efficiently remove heat and provide a low-impedance ground path, a thermal land is required on the surface of the PCB directly under the body of the package. During normal surface mount flow solder operations, the heat pad on the underside of the package is soldered to this thermal land creating an efficient thermal path. Normally, the PCB thermal land has a number of thermal vias within it that provide a thermal path to internal copper areas (or to the opposite side of the PCB) that provide for more efficient heat removal. TI typically recommends an 11.9-mm 2-board-mount thermal pad. This allows maximum area for thermal dissipation, while keeping leads away from the pad area to prevent solder bridging. A sufficient quantity of thermal/electrical vias must be included to keep the device within recommended operating conditions. This pad must be electrically ground potential.

**Thermal Considerations (continued)**



**Figure 28. Estimated Device Life at Elevated Temperatures Electromigration Fail Modes**

## 12 Device and Documentation Support

### 12.1 Device Support

#### 12.1.1 Definitions of Specifications and Terminology

- ACPR** or adjacent channel power ratio is defined for a 3.84-Mcps 3GPP W-CDMA input signal measured in a 3.84-MHz bandwidth at a 5-MHz offset from the carrier with a 12-dB peak-to-average ratio.
- APSSR** or analog power supply ratio is the percentage variation of full-scale output current versus a 5% variation of the analog power supply  $AV_{DD}$  from the nominal. This is a dc measurement.
- DPSSR** or digital power supply ratio is the percentage variation of full-scale output current versus a 5% variation of the digital power supply  $DV_{DD}$  from the nominal. This is a dc measurement.
- Gain error** is as the percentage error in the ratio between the measured full-scale output current and the value of  $16 \times V_{(EXTIO)}/R_{BIAS} \cdot A V_{(EXTIO)}$  of 1.25 V is used to measure the gain error with an external reference voltage applied. With an internal reference, this error includes the deviation of  $V_{(EXTIO)}$  (internal bandgap reference voltage) from the typical value of 1.25 V.
- Offset error** is as the percentage error in the ratio of the differential output current (IOUT1-IOUT2) and half of the full-scale output current for input code 8192.
- SINAD** is the ratio of the RMS value of the fundamental output signal to the RMS sum of all other spectral components below the Nyquist frequency, including noise and harmonics, but excluding dc.
- SNR** is the ratio of the RMS value of the fundamental output signal to the RMS sum of all other spectral components below the Nyquist frequency, including noise, but excluding the first six harmonics and dc.
- THD** is the ratio of the RMS sum of the first six harmonic components to the RMS value of the fundamental output signal.

### 12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 12.4 Trademarks

E2E is a trademark of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

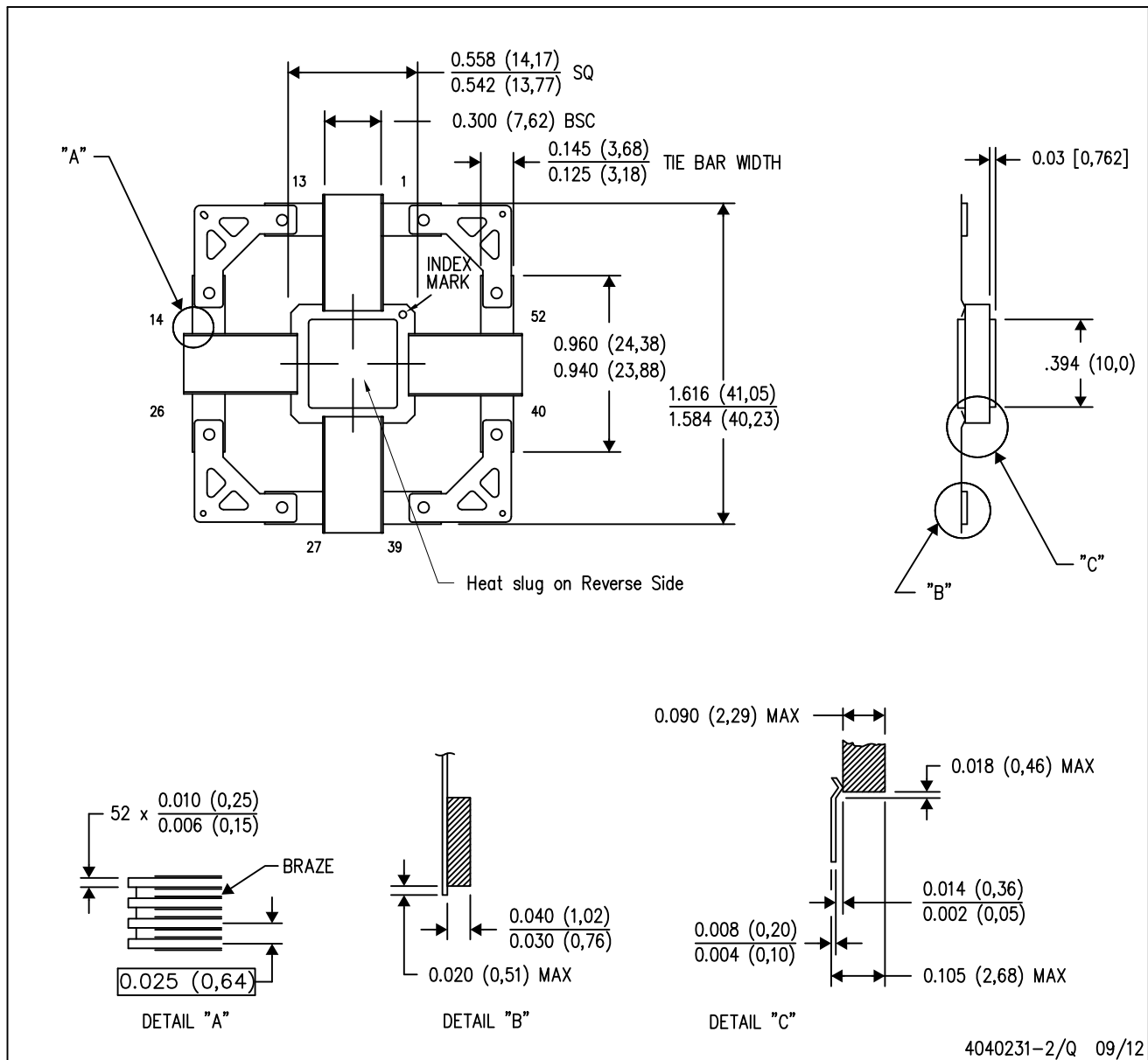
This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

HFG (S-CQFP-F52)

CERAMIC QUAD FLATPACK WITH NCTB



- NOTES:
- All linear dimensions are in inches (millimeters).
  - This drawing is subject to change without notice.
  - Ceramic quad flatpack with flat leads brazed to non-conductive tie bar carrier.
  - This package is hermetically sealed with a metal lid.
  - The leads are gold plated and can be solderdipped.
  - Leads not shown for clarity purposes.
  - Lid and heat sink are connected to GND leads.

**PACKAGING INFORMATION**

| Orderable part number           | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6)                    |
|---------------------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|--|
| <a href="#">5962-0720401VXC</a> | Active        | Production           | CFP (HFG)   52 | 10   JEDEC TRAY (5+1) | ROHS Exempt | Call TI                              | N/A for Pkg Type                  | -55 to 125   | 5962-0720401VXC<br>C<br>DAC5675AMHFG-V |
| <a href="#">5962-0720402VXC</a> | Active        | Production           | CFP (HFG)   52 | 10   JEDEC TRAY (5+1) | ROHS Exempt | Call TI                              | N/A for Pkg Type                  | -55 to 115   | 5962-0720402VXC<br>C<br>DAC5675AWHFG-V |
| <a href="#">DAC5675AHFG/EM</a>  | Active        | Production           | CFP (HFG)   52 | 10   JEDEC TRAY (5+1) | ROHS Exempt | Call TI                              | N/A for Pkg Type                  | 25 to 25     | DAC5675AHFG/EM<br>EVAL ONLY            |

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

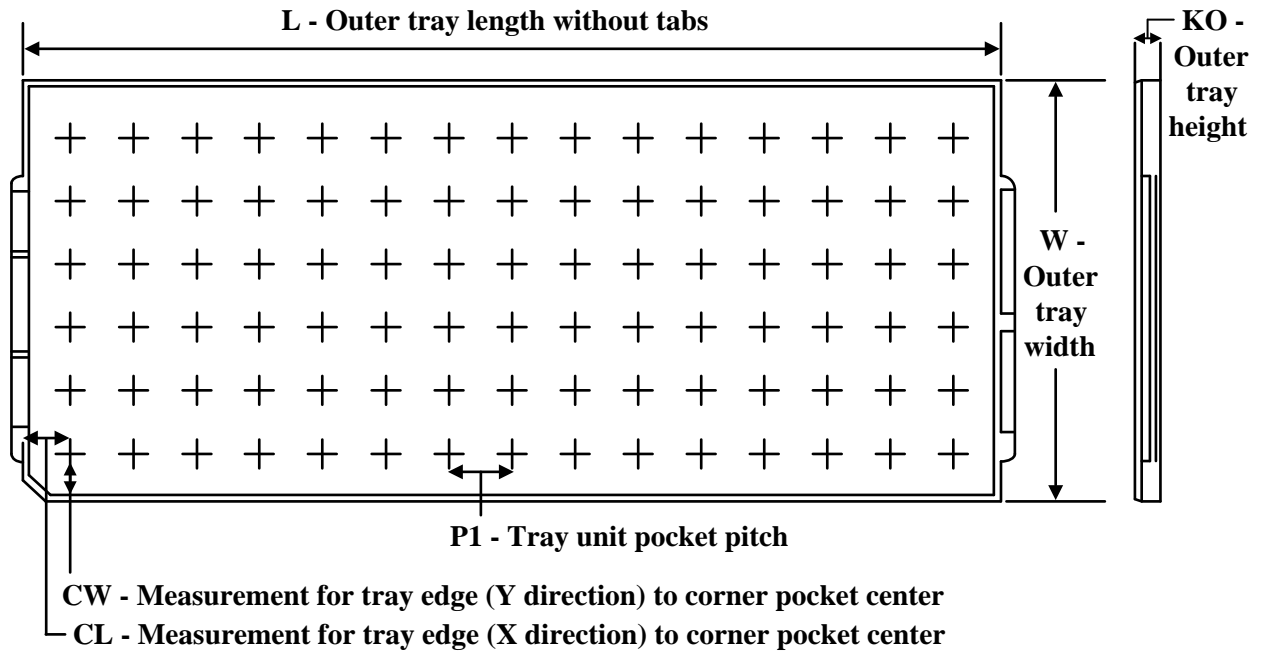
**OTHER QUALIFIED VERSIONS OF DAC5675A-SP :**

- Catalog : [DAC5675A](#)

## NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

**TRAY**



Chamfer on Tray corner indicates Pin 1 orientation of packed units.

\*All dimensions are nominal

| Device          | Package Name | Package Type | Pins | SPQ | Unit array matrix | Max temperature (°C) | L (mm) | W (mm) | K0 (µm) | P1 (mm) | CL (mm) | CW (mm) |
|-----------------|--------------|--------------|------|-----|-------------------|----------------------|--------|--------|---------|---------|---------|---------|
| 5962-0720401VXC | HFG          | CFP          | 52   | 10  | 2 x 5             | 75                   | 315    | 135.9  | 13000   | 60.96   | 35.58   | 37.47   |
| 5962-0720402VXC | HFG          | CFP          | 52   | 10  | 2 x 5             | 75                   | 315    | 135.9  | 13000   | 60.96   | 35.58   | 37.47   |
| DAC5675AHFG/EM  | HFG          | CFP          | 52   | 10  | 2 x 5             | 75                   | 315    | 135.9  | 13000   | 60.96   | 35.58   | 37.47   |



## GENERIC PACKAGE VIEW

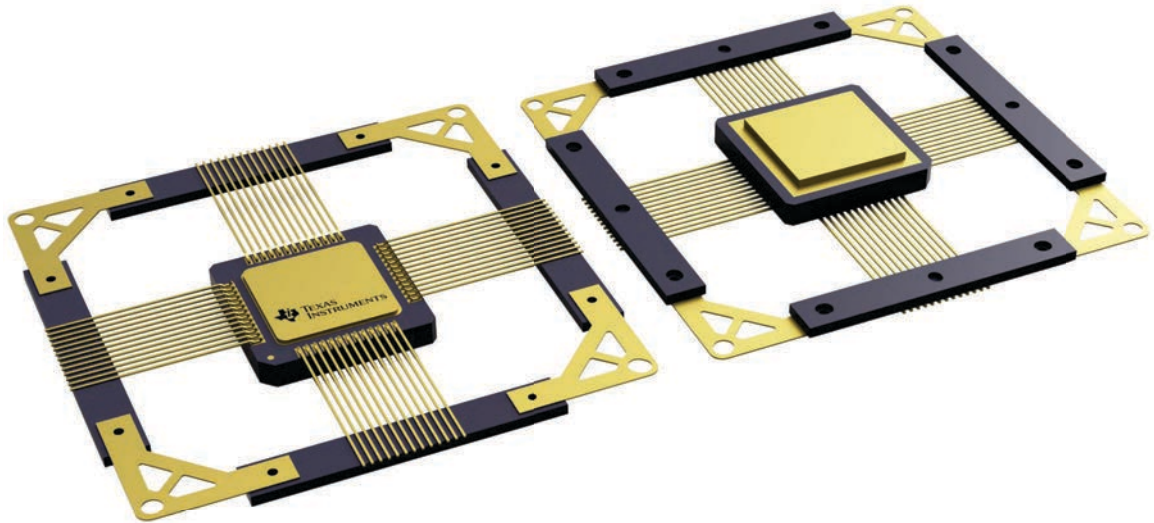
**HFG 52**

**CFP - 3.68 mm max height**

19.065 x 19.065, 0.635 mm pitch

CERAMIC FLATPACK

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



4229346/A

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#), [TI's General Quality Guidelines](#), or other applicable terms available either on [ti.com](#) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2026, Texas Instruments Incorporated

Last updated 10/2025